

# **PSMN016-100XS**

N-channel 100V 16 m $\Omega$  standard level MOSFET in TO220F (SOT186A)

Rev. 4 — 6 March 2012

**Product data sheet** 

#### **Product profile** 1.

#### **1.1 General description**

Standard level N-channel MOSFET in TO220F (SOT186A) package qualified to 175C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

#### 1.2 Features and benefits

High efficiency due to low switching and conduction losses

#### 1.3 Applications

- AC-to-DC power supply equipment
- Motor control

1.4 Quick reference data

- Isolated package
- Suitable for standard level gate drive
- Server power supplies
- Synchronous rectification

Table 1.	Quick reference data					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	-	100	V
I <sub>D</sub>	drain current	$T_{mb}$ = 25 °C; $V_{GS}$ = 10 V; see <u>Figure 1</u>	-	-	32.1	А
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>	-	-	46.1	W
Static cha	racteristics					
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS}$ = 10 V; $I_D$ = 10 A; $T_j$ = 25 °C; see <u>Figure 12</u> ; see <u>Figure 13</u>	-	13	16	mΩ
Dynamic	characteristics					
$Q_{GD}$	gate-drain charge	$V_{GS}$ = 10 V; $I_{D}$ = 10 A; $V_{DS}$ = 50 V;	-	14.2	-	nC
Q <sub>G(tot)</sub>	total gate charge	see <u>Figure 14;</u> see <u>Figure 15</u>	-	46.2	-	nC
Avalanch	e ruggedness					
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy		-	-	138	mJ



# **PSMN016-100XS**

N-channel 100V 16 mΩ standard level MOSFET in TO220F (SOT186A)

### 2. Pinning information

Table 2.	Pinning	j information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		_
2	D	drain	mb	
3	S	source		
mb		mounting base; isolated		mbb076 S

SOT186A (TO-220F)

### 3. Ordering information

#### Table 3.Ordering information

Type number	Package		
	Name	Description	Version
PSMN016-100XS	TO-220F	plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3-lead TO-220 "full pack"	SOT186A

# **PSMN016-100XS**

N-channel 100V 16 mΩ standard level MOSFET in TO220F (SOT186A)

### 4. Limiting values

#### Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Parameter	Conditions	Min	Max	Unit
drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	100	V
drain-gate voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C; R <sub>GS</sub> = 20 kΩ	-	100	V
gate-source voltage		-20	20	V
drain current	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; see <u>Figure 1</u>	-	32.1	А
	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 100 °C; see <u>Figure 1</u>	-	22.7	А
peak drain current	pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^{\circ}C$ ; see Figure 4	-	128	А
total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>	-	46.1	W
storage temperature		-55	175	°C
junction temperature		-55	175	°C
peak soldering temperature		-	260	°C
n diode				
source current	T <sub>mb</sub> = 25 °C	-	38.5	А
peak source current	pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^{\circ}C$	-	128	А
uggedness				
non-repetitive drain-source avalanche energy	$V_{GS} = 10 \text{ V}; T_{j(init)} = 25 \text{ °C}; I_D = 32.1 \text{ A};$ $V_{sup} \le 100 \text{ V};$ unclamped; $R_{GS} = 50 \Omega;$ see Figure 3	-	138	mJ
	drain-source voltage drain-gate voltage gate-source voltage drain current peak drain current total power dissipation storage temperature junction temperature peak soldering temperature <b>n diode</b> source current peak source current uggedness non-repetitive drain-source	$\begin{array}{ll} drain-source \ voltage & T_j \ge 25\ ^{\circ}\text{C};\ T_j \le 175\ ^{\circ}\text{C} \\ drain-gate \ voltage & T_j \ge 25\ ^{\circ}\text{C};\ T_j \le 175\ ^{\circ}\text{C};\ R_{GS} = 20\ \text{k}\Omega \\ gate-source \ voltage & \\ drain \ current & \frac{V_{GS} = 10\ \text{V};\ T_{mb} = 25\ ^{\circ}\text{C};\ see\ Figure\ 1}{V_{GS} = 10\ \text{V};\ T_{mb} = 100\ ^{\circ}\text{C};\ see\ Figure\ 1} \\ peak\ drain\ current & pulsed;\ t_p \le 10\ \mu\text{s};\ T_{mb} = 25\ ^{\circ}\text{C};\ see\ Figure\ 4} \\ total\ power\ dissipation & T_{mb} = 25\ ^{\circ}\text{C};\ see\ Figure\ 2} \\ storage\ temperature & \\ peak\ soldering\ temperature & \\ peak\ soldering\ temperature & \\ peak\ soldering\ temperature & \\ pulsed;\ t_p \le 10\ \mu\text{s};\ T_{mb} = 25\ ^{\circ}\text{C} \\ peak\ source\ current & T_{mb} = 25\ ^{\circ}\text{C} \\ peak\ source\ current & pulsed;\ t_p \le 10\ \mu\text{s};\ T_{mb} = 25\ ^{\circ}\text{C} \\ \\ uggedness & \\ non-repetitive\ drain-source & \\ v_{GS} = 10\ \text{V};\ T_{j(init)} = 25\ ^{\circ}\text{C};\ l_D = 32.1\ \text{A}; \\ v_{sup} \le 100\ \text{V};\ unclamped;\ R_{GS} = 50\ \Omega; \\ \end{array}$	$\begin{array}{ccc} drain-source voltage & T_j \geq 25 \ ^{\circ}\text{C}; \ T_j \leq 175 \ ^{\circ}\text{C} & - \\ drain-gate voltage & T_j \geq 25 \ ^{\circ}\text{C}; \ T_j \leq 175 \ ^{\circ}\text{C}; \ R_{GS} = 20 \ \text{k}\Omega & - \\ gate-source voltage & -20 \\ drain current & V_{GS} = 10 \ ^{\circ}\text{V}; \ T_{mb} = 25 \ ^{\circ}\text{C}; \ see \ Figure 1 & - \\ \hline V_{GS} = 10 \ ^{\circ}\text{V}; \ T_{mb} = 100 \ ^{\circ}\text{C}; \ see \ Figure 1 & - \\ \hline V_{GS} = 10 \ ^{\circ}\text{V}; \ T_{mb} = 100 \ ^{\circ}\text{C}; \ see \ Figure 1 & - \\ \hline v_{GS} = 10 \ ^{\circ}\text{V}; \ T_{mb} = 25 \ ^{\circ}\text{C}; \ see \ Figure 2 & - \\ total power dissipation & T_{mb} = 25 \ ^{\circ}\text{C}; \ see \ Figure 2 & - \\ storage temperature & -55 \\ junction temperature & -55 \\ peak soldering temperature & -55 \\ peak source current & T_{mb} = 25 \ ^{\circ}\text{C} & - \\ peak source current & pulsed; \ t_p \leq 10 \ \mu\text{s}; \ T_{mb} = 25 \ ^{\circ}\text{C} & - \\ \\ uggedness & \\ non-repetitive \ drain-source & \\ avalanche \ energy & V_{GS} = 10 \ ^{\circ}\text{V}; \ T_{j(init)} = 25 \ ^{\circ}\text{C}; \ I_D = 32.1 \ \text{A}; \\ V_{sup} \leq 100 \ ^{\circ}\text{V}; unclamped; \ R_{GS} = 50 \ \Omega; \end{array}$	$\begin{array}{cccc} drain-source voltage & T_j \geq 25\ {}^\circ C;\ T_j \leq 175\ {}^\circ C & - & 100 \\ drain-gate voltage & T_j \geq 25\ {}^\circ C;\ T_j \leq 175\ {}^\circ C;\ R_{GS} = 20\ k\Omega & - & 100 \\ gate-source voltage & -20 & 20 \\ drain current & V_{GS} = 10\ V;\ T_{mb} = 25\ {}^\circ C;\ see\ Figure\ 1 & - & 32.1 \\ V_{GS} = 10\ V;\ T_{mb} = 100\ {}^\circ C;\ see\ Figure\ 1 & - & 22.7 \\ peak\ drain\ current & pulsed;\ t_p \leq 10\ \mu s;\ T_{mb} = 25\ {}^\circ C;\ see\ Figure\ 4 & - & 128 \\ total\ power\ dissipation & T_{mb} = 25\ {}^\circ C;\ see\ Figure\ 2 & - & 46.1 \\ storage\ temperature & -55 & 175 \\ junction\ temperature & -55 & 175 \\ peak\ soldering\ temperature & -55 & 175 \\ peak\ soldering\ temperature & -55 & 175 \\ peak\ source\ current & T_{mb} = 25\ {}^\circ C & - & 38.5 \\ peak\ source\ current & T_{mb} = 25\ {}^\circ C;\ I_D = 32.1\ A; \\ pulsed;\ t_p \leq 10\ V;\ T_{j(init)} = 25\ {}^\circ C;\ I_D = 32.1\ A; \\ v_{sup} \leq 100\ V;\ unclamped;\ R_{GS} = 50\ \Omega; \\ \end{array}$

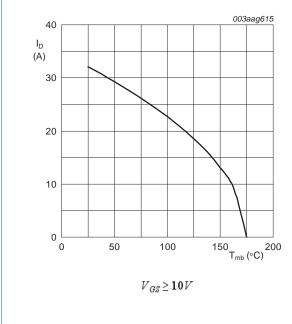


Fig 1. Continuous drain current as a function of mounting base temperature

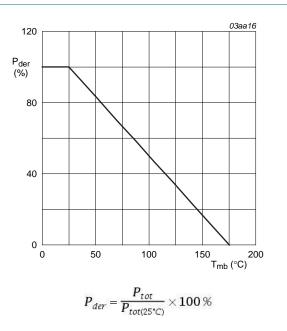
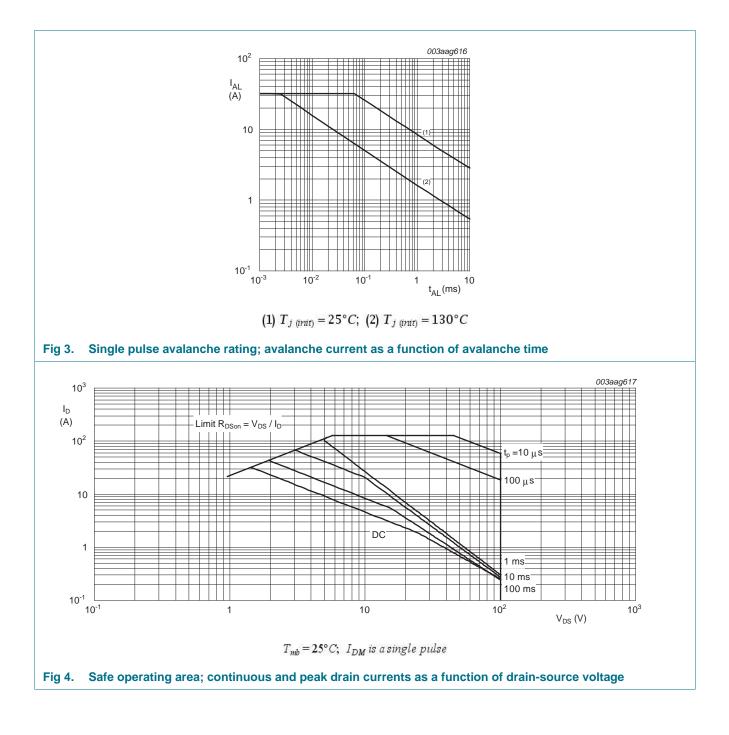


Fig 2. Normalized total power dissipation as a function of mounting base temperature

# **PSMN016-100XS**

#### N-channel 100V 16 m $\Omega$ standard level MOSFET in TO220F (SOT186A)



### 5. Thermal characteristics

Table 5.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	see Figure 5	-	3	3.25	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	vertical in free air	-	55	-	K/W

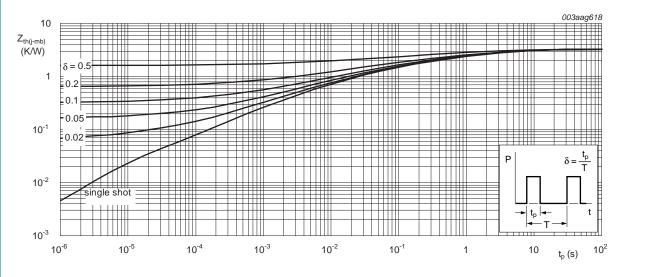


Fig 5. Transient thermal impedance from junction to mounting base as a function of pulse duration

### 6. Isolation characteristics

Table 6.	Isolation characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
C <sub>isol</sub>	isolation capacitance	f = 1 MHz	-	10	-	pF
V <sub>isol(RMS)</sub>	RMS isolation voltage	50 Hz $\leq$ f $\leq$ 60 Hz; RH $\leq$ 65 %; sinusoidal waveform: clean and dust free	-	-	2500	V

### 7. Characteristics

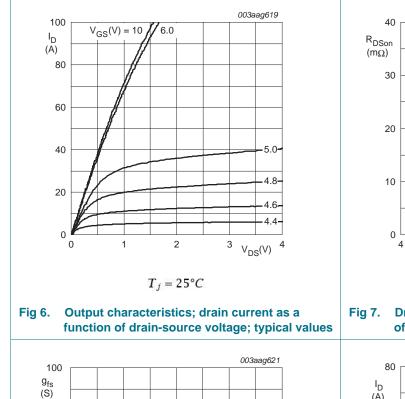
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
	racteristics			.71		
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	I <sub>D</sub> = 250 μA; V <sub>GS</sub> = 0 V; T <sub>i</sub> = 25 °C	100	-	-	V
- (BR)D33		$I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \ V; \ T_i = -55 \ ^{\circ}\text{C}$	90	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see Figure 10; see Figure 11	2	3	4	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ see Figure 10	1	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see Figure 10	-	-	4.6	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 100 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	5	μA
		V <sub>DS</sub> = 100 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 100 °C	-	-	100	μA
GSS	gate leakage current	V <sub>GS</sub> = 20 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	2	100	nA
		$V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nA
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS}$ = 10 V; $I_D$ = 10 A; $T_j$ = 25 °C; see Figure 12; see Figure 13	-	13	16	mΩ
		$V_{GS}$ = 10 V; $I_D$ = 10 A; $T_j$ = 100 °C; see Figure 13	-	22.8	28	mΩ
		$V_{GS}$ = 10 V; $I_D$ = 10 A; $T_j$ = 175 °C; see Figure 13	-	36.4	44.8	mΩ
R <sub>G</sub>	internal gate resistance (AC)	f = 1 MHz	-	0.9	-	Ω
Dynamic o	haracteristics					
Q <sub>G(tot)</sub>	total gate charge	$I_D = 10 \text{ A}; V_{DS} = 50 \text{ V}; V_{GS} = 10 \text{ V};$	-	46.2	-	nC
Q <sub>GS</sub>	gate-source charge	see Figure 14; see Figure 15	-	10.4	-	nC
Q <sub>GS(th)</sub>	pre-threshold gate-source charge		-	7.1	-	nC
Q <sub>GS(th-pl)</sub>	post-threshold gate-source charge		-	3.3	-	nC
Q <sub>GD</sub>	gate-drain charge		-	14.2	-	nC
V <sub>GS(pl)</sub>	gate-source plateau voltage	$I_D = 10 \text{ A}; V_{DS} = 50 \text{ V}; \text{ see } \frac{\text{Figure } 14}{\text{Figure } 15}$	-	4.5	-	V
C <sub>iss</sub>	input capacitance	$V_{DS} = 50 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ °C}; \text{ see } Figure 16;$ see Figure 17	-	2404	-	pF
C <sub>oss</sub>	output capacitance	$V_{DS} = 50 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 16}}{10000000000000000000000000000000000$	-	189	-	pF
C <sub>rss</sub>	reverse transfer capacitance	$V_{DS} = 50 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 16}{\text{Figure } 17}$	-	113	-	pF
d(on)	turn-on delay time	$V_{DS} = 50 \text{ V}; \text{ R}_{L} = 5 \Omega; V_{GS} = 10 \text{ V};$	-	16	-	ns
r	rise time	$R_{G(ext)} = 4.7 \ \Omega; \ T_{j} = 25 \ ^{\circ}C$	-	16	-	ns
d(off)	turn-off delay time		-	39	-	ns
t <sub>f</sub>	fall time		-	18	-	ns

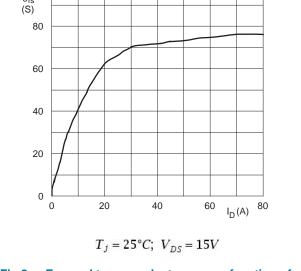
# **PSMN016-100XS**

#### N-channel 100V 16 mΩ standard level MOSFET in TO220F (SOT186A)

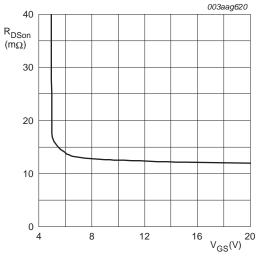
#### Table 7. Characteristics ...continued

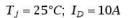
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Source-dra	ain diode					
V <sub>SD</sub>	source-drain voltage	$I_{S} = 10 \text{ A}; V_{GS} = 0 \text{ V}; T_{j} = 25 \text{ °C}$	-	0.8	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_{S} = 10 \text{ A}; \text{ dI}_{S}/\text{dt} = -100 \text{ A}/\mu\text{s};$	-	54	-	ns
Qr	recovered charge	$V_{GS} = 0 V; V_{DS} = 50 V$	-	126	-	nC













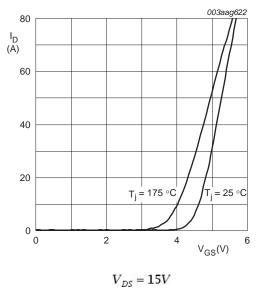
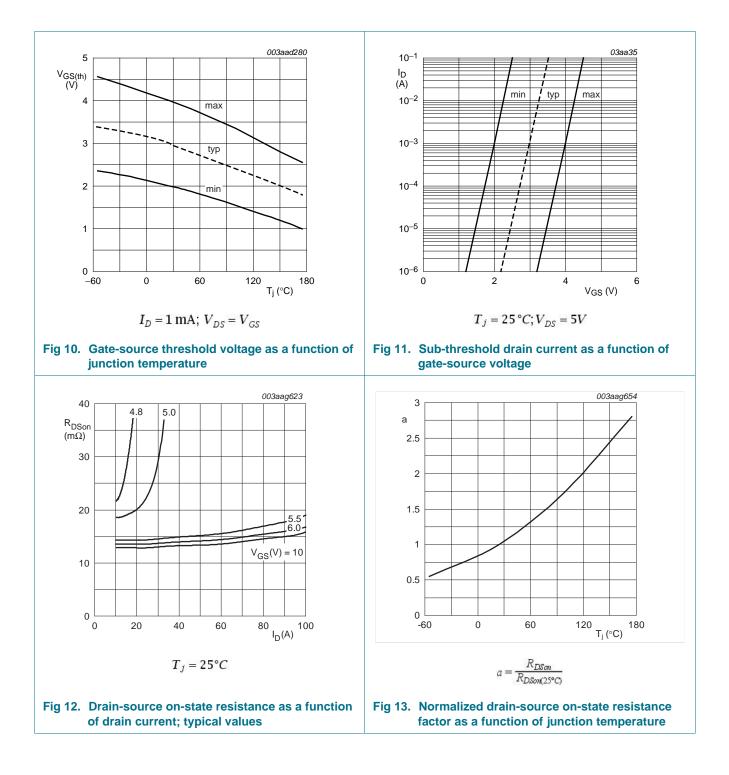


Fig 9. Transfer characteristics; drain current as a function of gate-source voltage; typical values

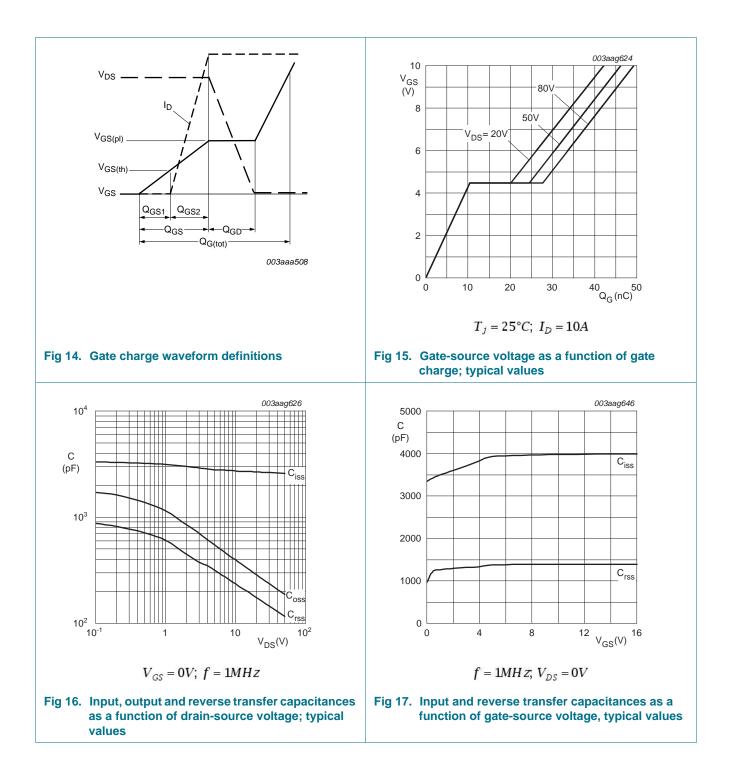
# **PSMN016-100XS**

#### N-channel 100V 16 mΩ standard level MOSFET in TO220F (SOT186A)



# **PSMN016-100XS**

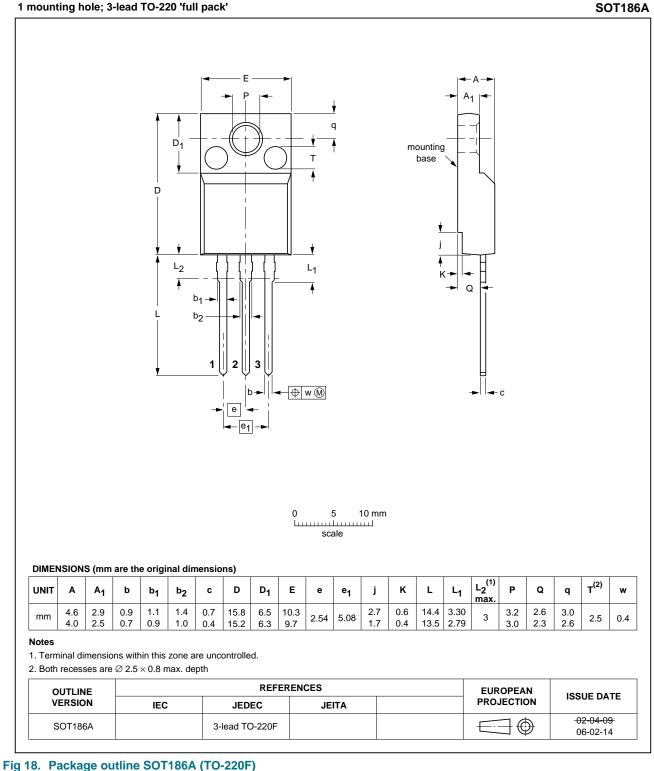
#### N-channel 100V 16 mΩ standard level MOSFET in TO220F (SOT186A)



## **PSMN016-100XS**

#### N-channel 100V 16 mΩ standard level MOSFET in TO220F (SOT186A)

#### **Package outline** 8.



Plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3-lead TO-220 'full pack'

PSMN016-100XS

### 9. Revision history

Table 8. Revision h	istory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN016-100XS v.4	20120306	Product data sheet	-	PSMN016-100XS v.3
Modifications:	<ul> <li>Status change</li> </ul>	d from preliminary to produc	x.	
	<ul> <li>Various chang</li> </ul>	es to content.		
PSMN016-100XS v.3	20111021	Preliminary data shee	t -	PSMN016-100XS v.2

### **10. Legal information**

#### 10.1 Data sheet status

Document status[1] [2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions'

The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product [3] status information is available on the Internet at URLhttp://www.nxp.com.

#### 10.2 Definitions

Preview — The document is a preview version only. The document is still subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between NXP Semiconductors and its customer, unless NXP Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the NXP Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet

### 10.3 Disclaimers

Limited warranty and liability - Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. NXP Semiconductors takes no responsibility for the content in this document if provided by an information source outside of NXP Semiconductors.

In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the Terms and conditions of commercial sale of NXP Semiconductors.

Right to make changes - NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use - NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors and its suppliers accept no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this respect.

Limiting values - Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

PSMN016-100XS

12 of 14

Rev. 4 — 6 March 2012

# **PSMN016-100XS**

#### N-channel 100V 16 mΩ standard level MOSFET in TO220F (SOT186A)

Terms and conditions of commercial sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published athttp://www.nxp.com/profile/terms, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

**Export control** — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Non-automotive qualified products — Unless this data sheet expressly states that this specific NXP Semiconductors product is automotive qualified, the product is not suitable for automotive use. It is neither qualified nor tested in accordance with automotive testing or application requirements. NXP Semiconductors accepts no liability for inclusion and/or use of non-automotive qualified products in automotive equipment or applications.

In the event that customer uses the product for design-in and use in automotive applications to automotive specifications and standards, customer (a) shall use the product without NXP Semiconductors' warranty of the

### **11. Contact information**

For more information, please visit:http://www.nxp.com

For sales office addresses, please send an email to:salesaddresses@nxp.com

product for such automotive applications, use and specifications, and (b) whenever customer uses the product for automotive applications beyond NXP Semiconductors' specifications such use shall be solely at customer's own risk, and (c) customer fully indemnifies NXP Semiconductors for any liability, damages or failed product claims resulting from customer design and use of the product for automotive applications beyond NXP Semiconductors' standard warranty and NXP Semiconductors' product specifications.

**Translations** — A non-English (translated) version of a document is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

#### **10.4 Trademarks**

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

Adelante,Bitport,Bitsound,CoolFlux,CoReUse,DESFire,EZ-HV,FabKey,G reenChip,HiPerSmart,HITAG,I<sup>2</sup>C-bus logo,ICODE,I-CODE,ITEC,Labelution,MIFARE,MIFARE Plus,MIFARE Ultralight,MoReUse,QLPAK,Silicon Tuner,SiliconMAX,SmartXA,STARplug,TOPFET,TrenchMOS,TriMedia andUCODE — are trademarks of NXP B.V.

HD Radio and HD Radio logo — are trademarks of iBiquity Digital Corporation.

# **PSMN016-100XS**

N-channel 100V 16 mΩ standard level MOSFET in TO220F (SOT186A)

### 12. Contents

1	Product profile1
1.1	General description1
1.2	Features and benefits1
1.3	Applications1
1.4	Quick reference data1
2	Pinning information2
3	Ordering information2
4	Limiting values3
5	Thermal characteristics5
6	Isolation characteristics5
7	Characteristics6
8	Package outline10
9	Revision history11
10	Legal information12
10.1	Data sheet status
10.2	Definitions12
10.3	Disclaimers
10.4	Trademarks
11	Contact information13

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

© NXP B.V. 2012.

All rights reserved.

For more information, please visit: http://www.nxp.com For sales office addresses, please send an email to: salesaddresses@nxp.com

Date of release: 6 March 2012 Document identifier: PSMN016-100XS